PHYC 3540

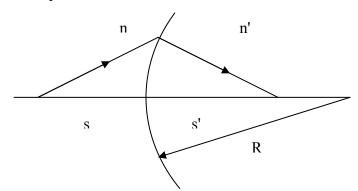
Summary

I. Propagation of light

- a. History, wave vs. particle picture
- b. Fermats Principle actual path is that for which the OPL is an extremum
- c. Huygen's principle every point on wavefront acts as a source
 - i. Large aperture ($>>\lambda$) rectilinear propagation (Geometric optics)
 - ii. Small aperture ($\geq \lambda$) spreading of wavefront (Diffraction)
- d. Wavefronts, Rays Laws of reflection and refraction (Snels law)

II. Geometric Optics

- a. Imaging Cartesian surfaces, Paraxial ray approximation
- b. Refraction at a Spherical interface



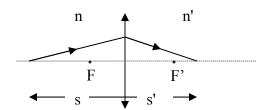
$$\frac{n}{s} + \frac{n'}{s'} = \frac{n'-n}{R} = \frac{n}{f} = \frac{n'}{f'}$$

$$\frac{n}{f} = \frac{n'}{f'} = P \equiv Power$$

c. Thin lens

$$\frac{n}{s} + \frac{n'}{s'} = \frac{n_L - n}{R_1} - \frac{n_L - n'}{R_2} = \frac{n}{f} = \frac{n'}{f'} = P$$

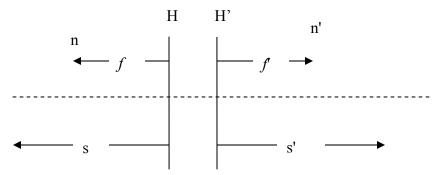
Magnification $M = \frac{h'}{h} = -\frac{ns'}{n's}$ for all imaging



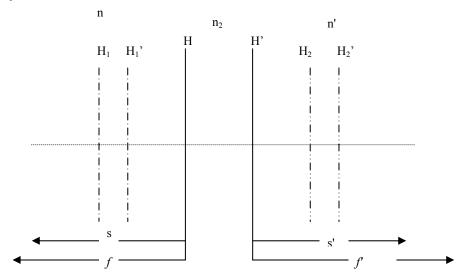
- d. Principal Planes (H,H')
 - i. Used to represent any optical element or system and are located such that the system images an object according to:

$$\frac{n}{s} + \frac{n'}{s'} = \frac{n}{f} = \frac{n'}{f'} = P$$

ii. The principal planes used to represent a spherical interface (or thin lens) must coincide at the interface (or centre of the thin lens).



e. Combination of two systems



i. Power of combined system $P = P_1 + P_2 - \frac{dP_1P_2}{n_2}$

where,
$$P_1 = \frac{n}{f_1} = \frac{n_2}{f_1}$$
 and $P_2 = \frac{n_2}{f_2} = \frac{n'}{f_2}$

ii. The location of H, H' are determined with respect to H₁ and H₂' as

$$h' = H_2'H' = -d\left(\frac{P_1}{P}\right)\left(\frac{n'}{n_2}\right) = -d\frac{f'}{f_1'}$$
follows:
$$h = H_1H = d\left(\frac{P_2}{P}\right)\left(\frac{n}{n_2}\right) = d\frac{f}{f_2}$$

- f. Matrix methods in paraxial optics
 - i. Matrices

Translation matrix
$$\begin{bmatrix} 1 & L \\ 0 & 1 \end{bmatrix}$$

Refraction matrix
$$\begin{bmatrix} 1 & 0 \\ \frac{n-n'}{Rn'} & \frac{n}{n'} \end{bmatrix}$$

Reflection matrix
$$\begin{bmatrix} 1 & 0 \\ \frac{2}{R} & 1 \end{bmatrix}$$

Thin lens matrix
$$\begin{bmatrix} 1 & 0 \\ -\frac{1}{f} & 1 \end{bmatrix}$$

ii. Cardinal point locations

$$h' = -d \frac{P_1}{P} \left(\frac{n'}{n_2} \right) = \frac{1 - A}{C}$$

$$h = d \frac{P_2}{P} \left(\frac{n}{n_2} \right) = \frac{D - \left(\frac{n}{n_1} \right)}{C}$$

- g. Stops in optical systems
 - i. Aperture stop
 - Element that limits the bundle of rays (and hence light gathering power or speed) collected by optical system
 - Is that element whose entrance pupil subtends the smallest angle at the object point in question
 - Exit pupil is the image of the aperture stop in all elements following it
 - Entrance pupil is the image of the aperture stop in all elements preceding it

- ii. Field stop
 - Element of the optical system that limits the field of view
 - That element whose entrance window subtends the smallest angle at the centre of the entrance pupil
 - Exit window is the image of the field stop in all elements following it.
 - Entrance window is the image of the field stop in all elements preceding it
- iii. Chief ray, marginal rays definition of edge of field of view
- iv. Angular field of view
 - Image space angle formed by the entrance window as viewed from the centre of the entrance pupil
 - Object space angle formed by the exit window as viewed from the centre of the exit pupil
- h. Applications
 - i. Cameras (aperture settings (f#), exposure, telephoto lens)
 - ii. Human eye myopia, hyperopia
 - iii. Hand magnifiers, eyepieces, compound microscope
 - iv. Telescope, binoculars
- III. **Physical optics** (wave properties are important)
 - a. Wave equation plane waves, spherical waves, cylindrical waves
 - b. Amplitude reflection and transmission co-efficients

$$\rho_{12} = \frac{v_2 - v_1}{v_1 + v_2} \quad ; \quad \tau_{12} = \frac{2v_2}{v_1 + v_2}$$

- c. Electromagnetic waves $(E \perp B; E, B \text{ in phase, speed c/n})$
 - i. Irradiance

$$I = \frac{1}{2} \varepsilon v E_o^2$$
 ; $E_o = Amplitude$

ii. Transmittance

$$T = \frac{I_2}{I_1} = 4 \frac{n_1 n_2}{(n_1 + n_2)^2} = \tau_{12} \tau_{21} = \frac{n_2}{n_1} \tau_{12}^2$$

iii. Reflectance $(1\rightarrow 2)$

$$R = \frac{I_R}{I_1} = \left(\frac{n_2 - n_1}{n_2 + n_1}\right)^2 = \rho_{12}^2 = \rho_{21}^2$$

- d. Interference
 - i. Two source interference
 - Irradiance

$$I = I_1 + I_2 + 2\sqrt{I_1I_2}\cos(\phi_2 - \phi_1)$$

where,
$$\phi_2 - \phi_1 = \delta = k(r_2 - r_1) + (\varepsilon_2 - \varepsilon_1)$$

• If $\varepsilon_1 = \varepsilon_2$ and $I_1 = I_2 = I_0$ there are maxima located at,

$$\sin\theta = \pm m \frac{\lambda}{a}$$

- Examples
 - ➤ Double slit, Lloyds mirror, radio towers
 - ➤ Dielectric layers, e.g. Haidinger bands, fringes of equal thickness observed in oil films, air wedges
 - ➤ Antireflection coatings
 - ➤ Newton's rings
- ii. Multiple beam interference (coated dielectric layers)
 - Transmitted irradiance

$$I_{T} = \frac{T^{2}I_{o}}{(1-R)^{2}} \left(\frac{1}{1 + \frac{4R}{(1-R)^{2}} \sin^{2} \frac{\delta}{2}} \right)$$

where, $\frac{\delta}{2} = k_o nd \cos \theta$ and n, θ pertain to the

dielectric layer.

> Irradiance maxima occur when

$$2nd\cos\theta' = \pm m\lambda_o$$

- Fabry-Perot Interferometer
 - ➤ Finesse =

$$\mathfrak{I} = \frac{separation \quad between \quad fringes}{fringe \quad width \quad (FWHM)} = \frac{\pi \sqrt{R}}{1 - R}$$

> Free spectral range

$$\Delta \lambda_{FSR} = \frac{\lambda^2}{2nd}$$
 ; $\Delta \widetilde{v}_{FSR} = \frac{1}{2nd}$

> Fringe width

$$\Delta \lambda = \frac{free \ spectral \ range}{finesse} = \frac{\lambda^2}{2nd\Im}$$

> Spectral Resolution

$$\Re = \frac{\lambda}{\Delta \lambda_{\min}} = \frac{2nd\Im}{\lambda}$$

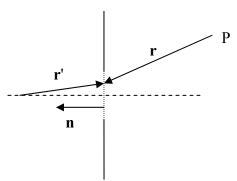
$$\mathfrak{R} = \frac{\widetilde{v}}{\Delta \widetilde{v}} = 2nd\widetilde{v}\mathfrak{I}$$

e. Diffraction

i. <u>Fresnel–Kirchoff diffraction</u> formula (Mathematical statement of Huygen's principle)

$$E = \frac{-ikE_o}{2\pi} \int_{aperture} \frac{e^{ik(r+r')}}{rr'} F(\theta) dA$$
where,

$$F(\theta) = \frac{1}{2} [\cos(\hat{n}, \vec{r}) - \cos(\hat{n}, \vec{r}')] = obliquity \quad factor$$



ii. Fraunhofer limit (plane waves)

diffraction integral reduces to $E = C' \int_{aperture}^{e^{ikr}} dA$

• Single slit (width b)

$$I = I_o \left(\frac{\sin \beta}{\beta}\right)^2$$
 where, $\beta = \frac{kb \sin \theta}{2}$

$$I = 0$$
 when $\sin \theta = \pm m \frac{\lambda}{h}$

• Circular aperture (diameter $d_0 = 2a_0$)

$$I = I_o \left(\frac{2J_1(\gamma)}{\gamma}\right)^2$$
 where, $\gamma = ka_0 \sin\theta$

$$I = 0$$
 when $\sin \theta = \frac{1.22\lambda}{a_o}$

Airy disc; Spatial resolution of optical devices; focussing limit

• N slits (width b, separation a)

$$I = I_o \left(\frac{\sin \beta}{\beta}\right)^2 \left(\frac{\sin N\alpha}{\alpha}\right)^2 \text{ where, } \alpha = \frac{ka \sin \theta}{2}$$

Principal maxima when $\sin \theta = \pm p \frac{\lambda}{a}$

Diffraction gratings

Grating dispersion

Spectral resolution $\Re = mN$

- f. Polarization
 - i. Jones vector for polarization

General
$$\begin{bmatrix} E_{ox} \\ E_{oy}e^{i\delta} \end{bmatrix}$$

Vertical
$$\begin{bmatrix} 0 \\ 1 \end{bmatrix}$$
 Horizontal $\begin{bmatrix} 1 \\ 0 \end{bmatrix}$

$$\begin{bmatrix} 0 \end{bmatrix}$$
 $e \pm \alpha, (-1)^m \begin{bmatrix} \cos \alpha \end{bmatrix}$

Linearly polarized at an angle $\pm \alpha$, $(-1)^m \begin{vmatrix} \cos \alpha \\ \sin \alpha \end{vmatrix}$

Left Circularly polarized $\frac{1}{\sqrt{2}} \begin{vmatrix} 1 \\ i \end{vmatrix}$ (i.e. counterclockwise)

Right Circularly polarized $\frac{1}{\sqrt{2}} \begin{vmatrix} 1 \\ -i \end{vmatrix}$ (i.e. clockwise)

Left Elliptically polarized
$$\frac{1}{\sqrt{A^2 + B^2 + C^2}} \begin{bmatrix} A \\ B + iC \end{bmatrix}$$

Right Elliptically polarized
$$\frac{1}{\sqrt{A^2 + B^2 + C^2}} \begin{bmatrix} A \\ B - iC \end{bmatrix}$$

where,
$$E_{ox} = A$$
 $E_{oy} = \sqrt{B^2 + C^2}$ $\delta = \tan^{-1} \left(\frac{C}{B}\right)$

and the angle of inclination, α , of the ellipse is given by

$$\tan(2\alpha) = \frac{2E_{ox}E_{oy}}{E_{ox}^2 - E_{oy}^2}$$

- ii. Jones matrices for optical elements
 - Linear polarizer (Transmission axis at an angle θ wrt x-

$$\begin{bmatrix} \cos^2\theta & \sin\theta\cos\theta\\ \sin\theta\cos\theta & \sin^2\theta \end{bmatrix}$$

Phase retarders

In general,
$$\begin{bmatrix} e^{i\epsilon_x} & 0 \\ 0 & e^{i\epsilon_y} \end{bmatrix}$$
 where, ϵ_x and ϵ_y represent

the advance in phase of the components

$$e^{-i\pi/4}\begin{bmatrix} 1 & 0 \\ 0 & i \end{bmatrix}$$
 Slow axis vertical

$$e^{+i\pi/4}\begin{bmatrix} 1 & 0 \\ 0 & -i \end{bmatrix}$$
 Slow axis horizontal

$$ightharpoonup$$
 Half wave plate ($|\varepsilon_y - \varepsilon_x| = \pi$)

Half wave plate
$$(|\varepsilon_y - \varepsilon_x| = \pi)$$

$$e^{-i\pi/2} \begin{bmatrix} 1 & 0 \\ 0 & -1 \end{bmatrix}$$
 Slow axis vertical
$$e^{+i\pi/2} \begin{bmatrix} 1 & 0 \\ 0 & -1 \end{bmatrix}$$
 Slow axis horizontal

Rotator (light polarized at an angle θ is rotated by an angle

$$\begin{bmatrix} \cos \beta & -\sin \beta \\ \sin \beta & \cos \beta \end{bmatrix}$$

g. Holography

i. Hologram

$$R(x, y, z) = r(x, y, z)e^{i\psi(x, y, z)} = re^{ikz}$$

$$O(x, y, z) = o(x, y, z)e^{i\phi(x, y, z)} = oe^{ikr}$$

where $r = \sqrt{x^2 + y^2 + z^2}$

$$I(x, y) \propto |O + R|^2 = OO^* + RR^* + OR^* + O^*R$$

where, R - reference wave, O - object wave, I - intensity

ii. Reconstructed wave

$$R(x, y)t_p = (t_b + BOO^*)R + BR^2O^* + B|R|^2O$$

where, t - transmission, first term - direct wave, second term – conjugate wave, third term – object wave